

General Description

The Sanrise SRC60R108B is a high voltage power MOSFET, fabricated using advanced super junction technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and outstanding efficiency.

The SRC60R108B break down voltage is 600V and it has a high rugged avalanche characteristics. The SRC60R108B is available in TO-247, TO-220C, TO-263-2 and TO-220F packages.

Features

- Ultra Low $R_{DS(ON)} = 108m\Omega @ V_{GS} = 10V$.
- Ultra Low Gate Charge, $Q_g=67.6nC$ typ.
- Intrinsic Fast-Recovery Body Diode
- Fast switching capability
- Robust design with better EAS performance

Application

- Sever / Telecom Power

Symbol

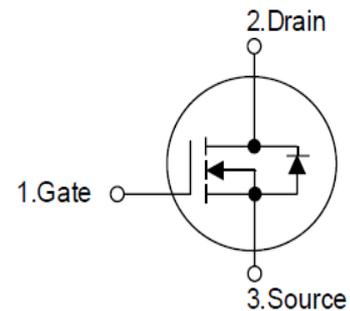


Figure 1 Symbol of SRC60R108B

Package Type

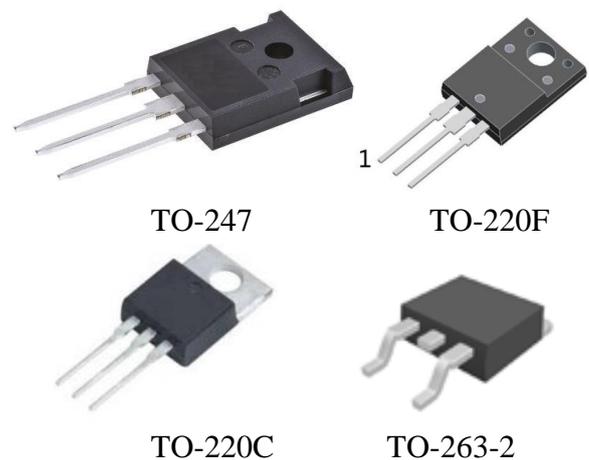
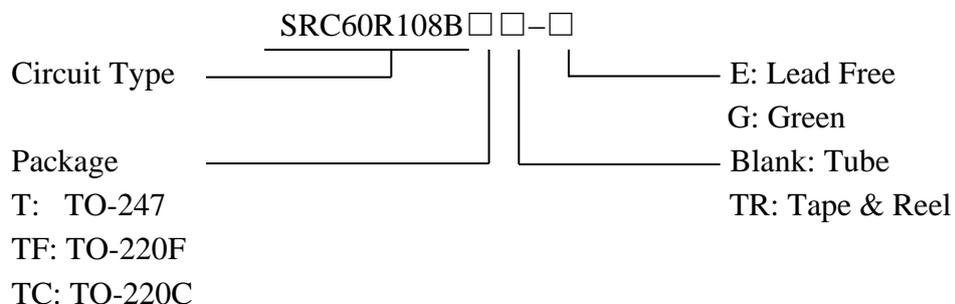


Figure 2 Package Types of SRC60R108B

Ordering Information



Package	Part Number		Marking ID		Packing Type
	Lead Free	Green	Lead Free	Green	
TO-247	SRC60R108BT-E	SRC60R108BT-G	SRC60R108BTE	SRC60R108BTG	Tube
TO-220F	SRC60R108BTF-E	SRC60R108BTF-G	SRC60R108BTFE	SRC60R108BTFG	Tube
TO-220C	SRC60R108BTC-E	SRC60R108BTC-G	SRC60R108BTCE	SRC60R108BTCG	Tube
TO-263-2	SRC60R108BS2TR-E	SRC60R108BS2TR-G	SRC60R108BS2E	SRC60R108BS2G	Tape & Reel

Absolute Maximum Ratings

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage (static)		V_{GSS}	±20	V
Gate-Source Voltage (dynamic), AC (f>1 Hz)		V_{GSS}	±30	V
Continuous Drain Current	$T_C=25^{\circ}C$	I_D	31.3	A
	$T_C=125^{\circ}C$		14.0	
Pulsed Drain Current (Note 2)		I_{DM}	93.9	A
Avalanche Energy, Single Pulse (Note 3)		E_{AS}	390	mJ
Avalanche Energy, Repetitive (Note 2)		E_{AR}	0.4	mJ
Avalanche Current, Repetitive (Note 2)		I_{AR}	3.0	A
Continuous Diode Forward Current		I_S	31.3	A
Diode Pulse Current		$I_{S,PULSE}$	93.9	A
MOSFET dv/dt Ruggedness, $V_{DS} \leq 480V$		dv/dt	50	V/ns
Reverse Diode dv/dt, $V_{DS} \leq 480V, I_{SD} \leq I_D$		dv/dt	50	V/ns
Operating Junction Temperature		T_J	150	°C
Storage Temperature		T_{STG}	-55 to 150	°C
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	°C

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $I_{AS} = 3.0A, V_{DD} = 60V, R_G = 25\Omega, \text{Starting } T_J = 25^{\circ}C$

Thermal Resistance

Parameter		Symbol	Min	Typ	Max	Unit
Thermal resistance, Junction-to-Case	TO-220F	R_{thJC}			3.6	°C /W
	TO-220C				0.6	
	TO-263-2				0.6	
	TO-247				0.6	
Thermal resistance, Junction-to-Ambient	TO-220F	R_{thJA}			80	°C /W
	TO-220C				62	
	TO-263-2				62	
	TO-247				62	

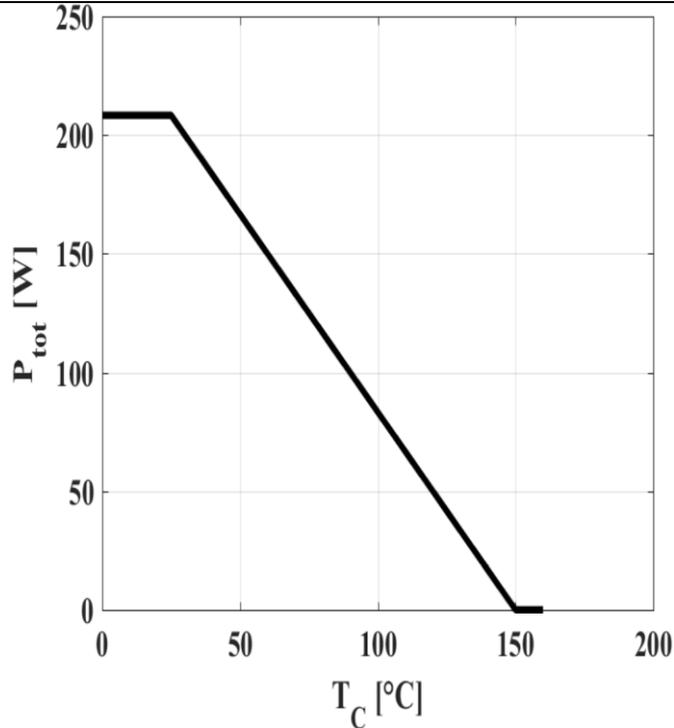
Electrical Characteristics
 $T_J = 25^{\circ}\text{C}$, unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			10	μA
Gate-Body Leakage Current	Forward	$I_{GSSF}, V_{GS}=20V, V_{DS}=0V$			100	nA
	Reverse	$I_{GSSR}, V_{GS}=-20V, V_{DS}=0V$			-100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=0.8mA$	3.0	4.0	5.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=10.5A$		89	108	$m\Omega$
Gate Resistance	R_G	$f=1MHz, \text{Open Drain}$		1.0		Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=50V, V_{GS}=0V, f=1MHz$		2.6		nF
Output Capacitance	C_{OSS}			104		pF
Reverse Transfer Capacitance	C_{RSS}			1.7		
Effective output capacitance, energy related ^{NOTE5}	$C_{O(er)}$	$V_{GS}=0V, V_{DS}=0\dots 400V$		57.5		pF
Effective output capacitance, time related ^{NOTE6}	$C_{O(tr)}$			335.7		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=400V, I_D=16A, R_G=5.3\Omega, V_{GS}=10V$		14		ns
Rise Time	t_r			12		
Turn-off Delay Time	$t_{d(off)}$			60		
Fall Time	t_f			6		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=480V, I_D=16A, V_{GS}=0 \text{ to } 10V$		17.1		nC
Gate to Drain Charge	Q_{gd}			34.1		
Gate Charge Total	Q_g			67.6		
Gate Plateau Voltage	$V_{plateau}$			6.5		V
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=16A$		0.9	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=100V, I_F=16A, dI_F/dt=100A/\mu s$		140		ns
Reverse Recovery Charge	Q_{rr}			0.77		μC
Peak Reverse Recovery Current	I_{rrm}			11		A

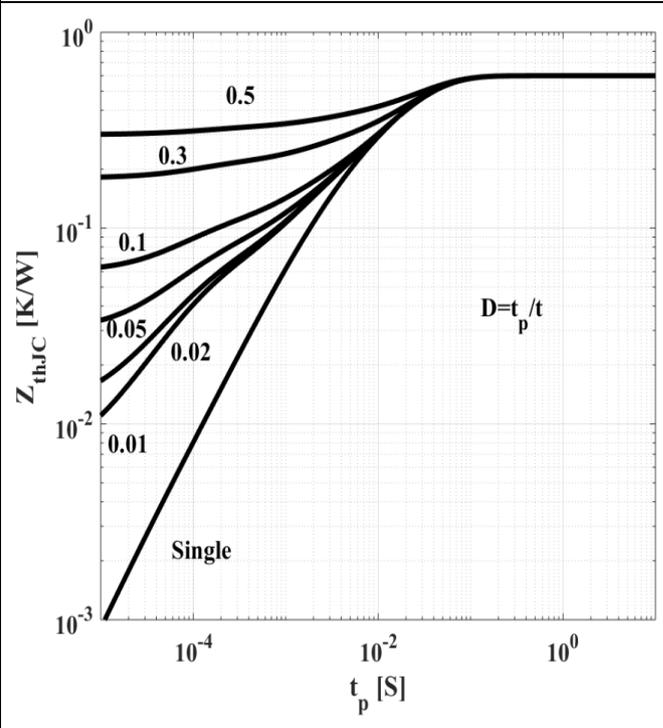
Note:

 5. $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 400V

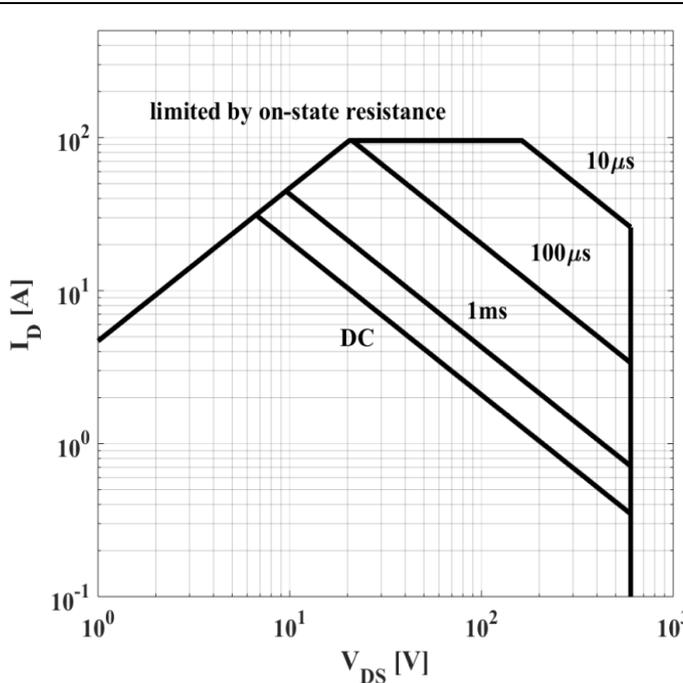
 6. $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 400 V

Typical Performance Characteristics
Figure 3: Power Dissipation


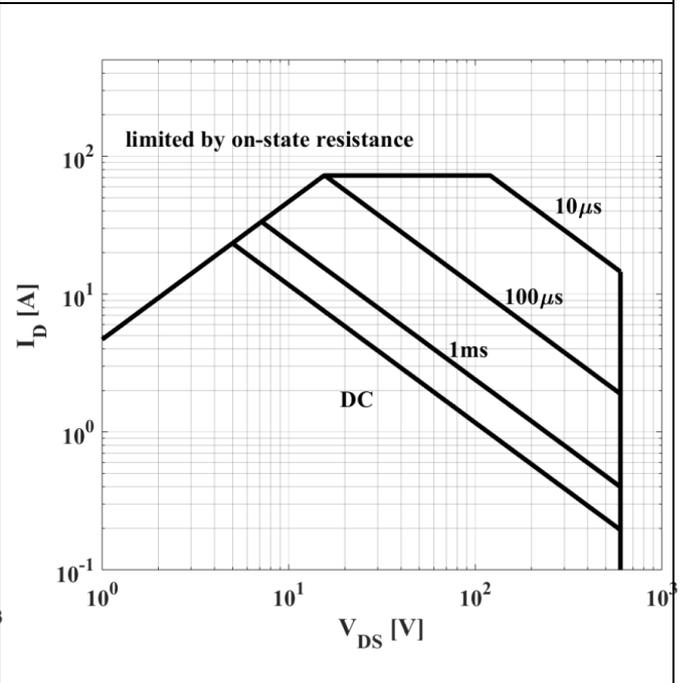
$$P_{tot} = f(T_c)$$

Figure 4: Max. Transient Thermal Impedance


$$Z_{thJC} = f(t_p); \text{ parameter: } D = t_p/T$$

Figure 5: Safe Operating Area


$$I_D = f(V_{DS}); T_c = 25^\circ\text{C}; V_{GS} > 7\text{V}; \text{ parameter } t_p$$

Figure 6: Safe Operating Area


$$I_D = f(V_{DS}); T_c = 80^\circ\text{C}; V_{GS} > 7\text{V}; \text{ parameter } t_p$$

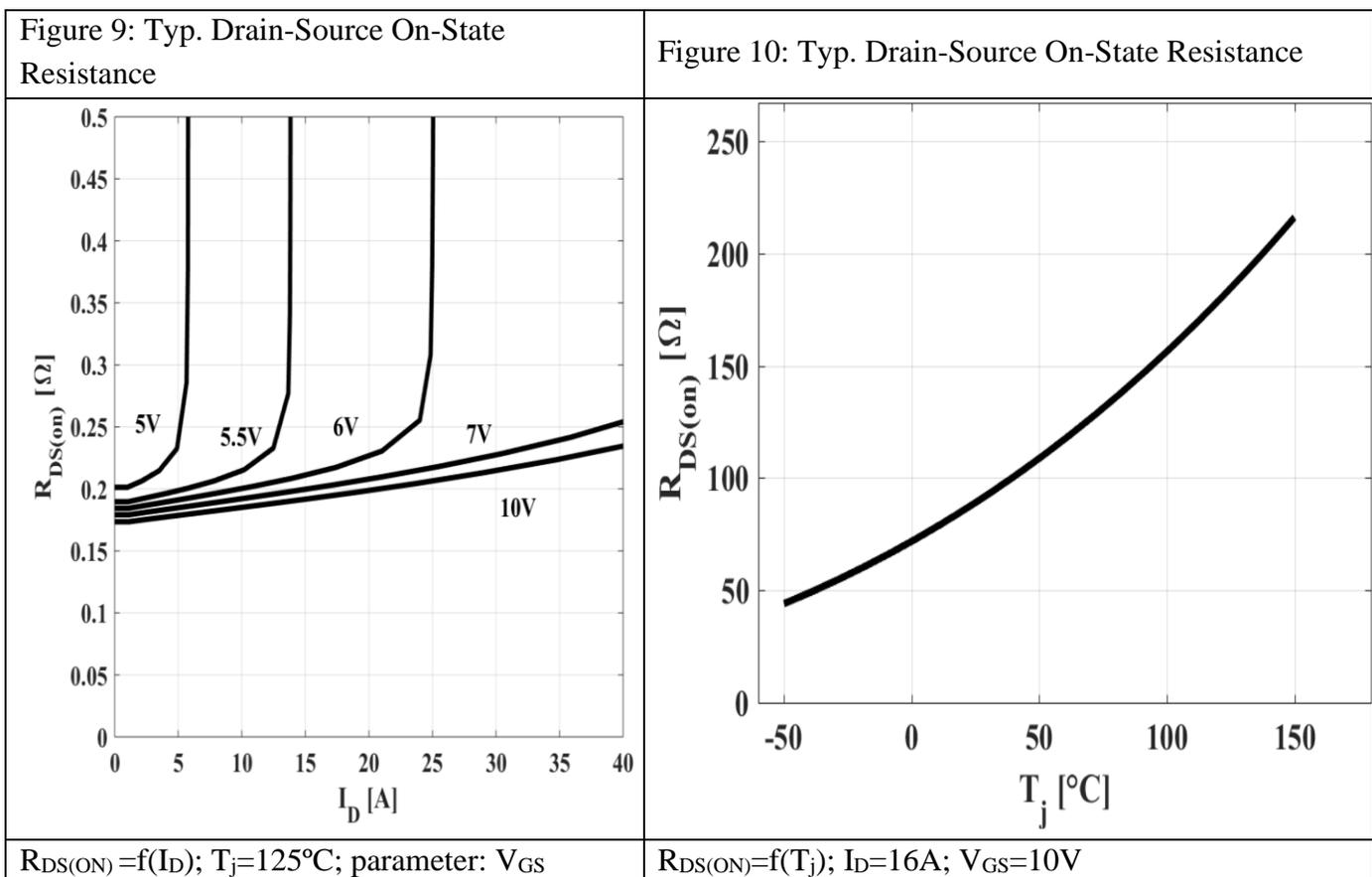
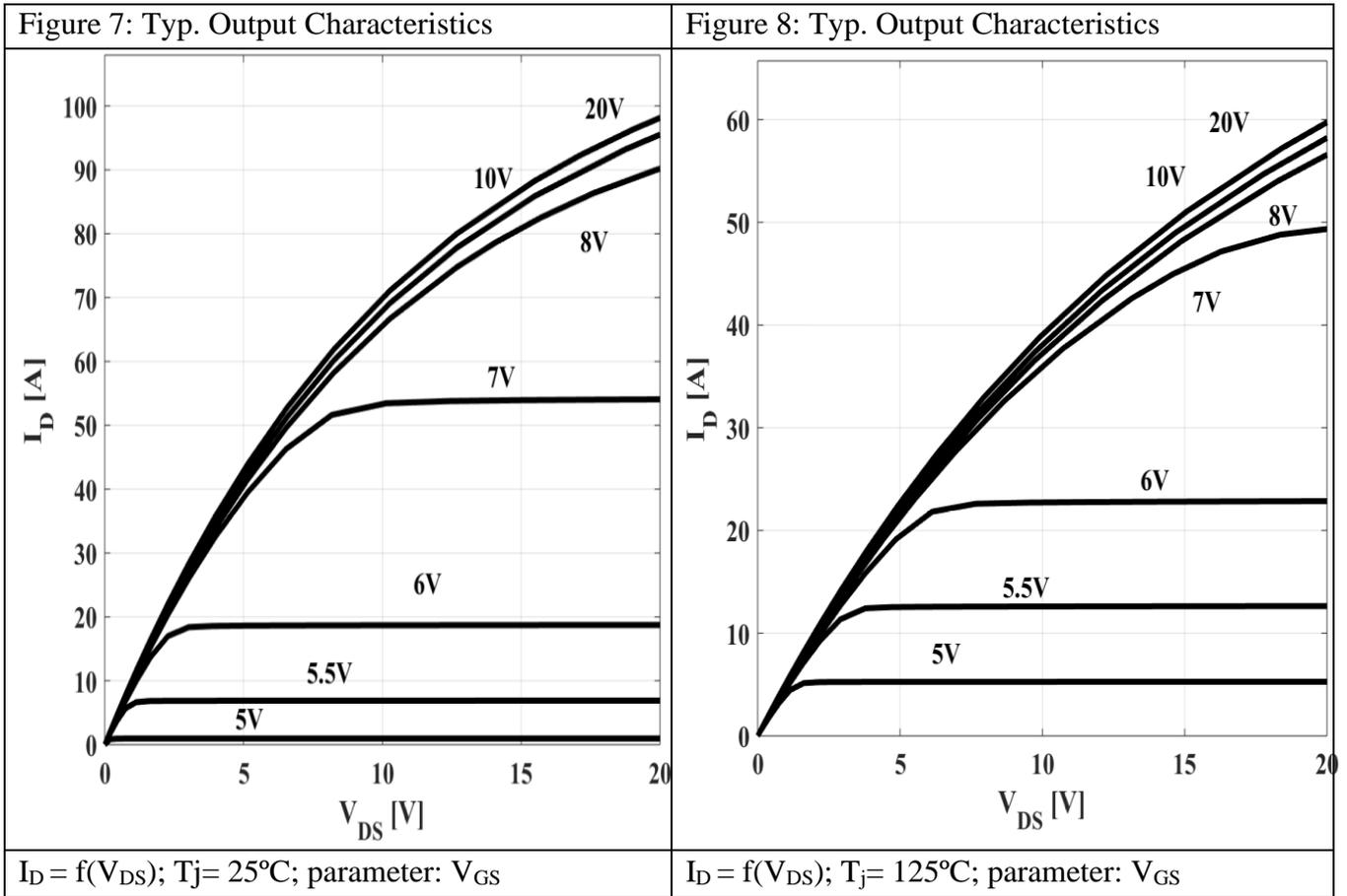


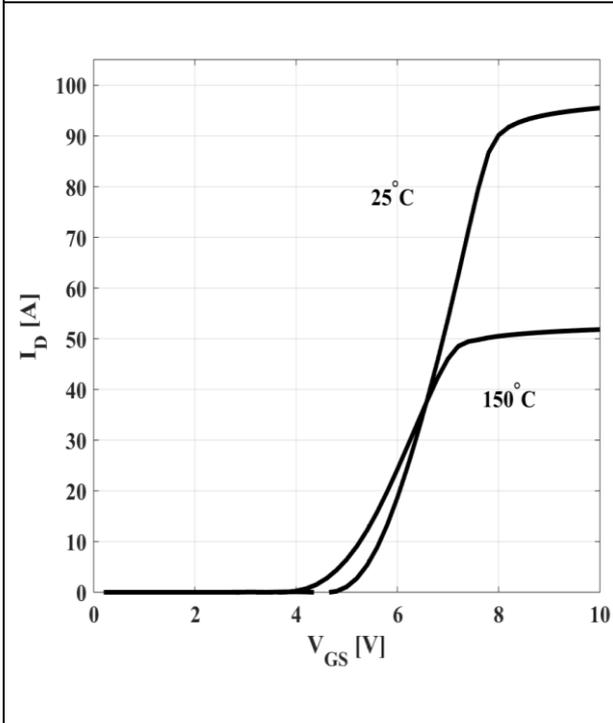
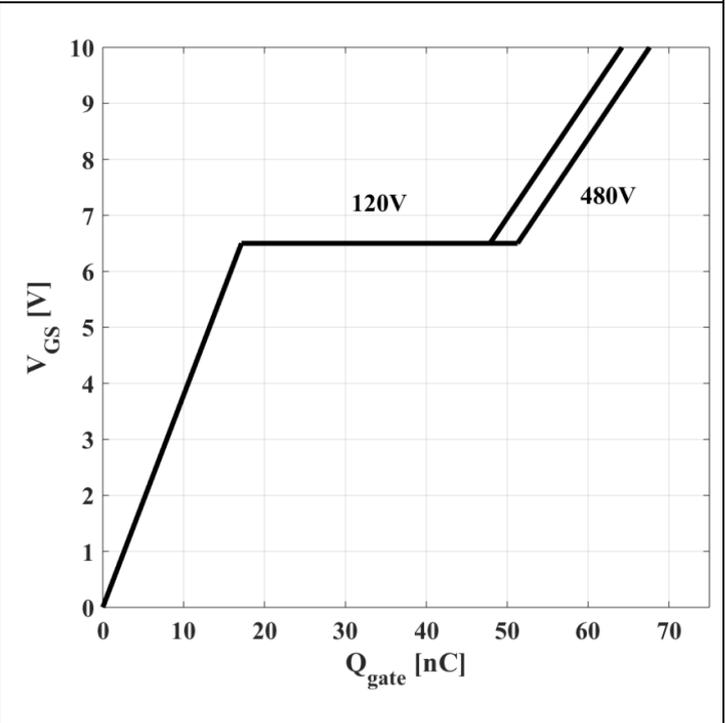
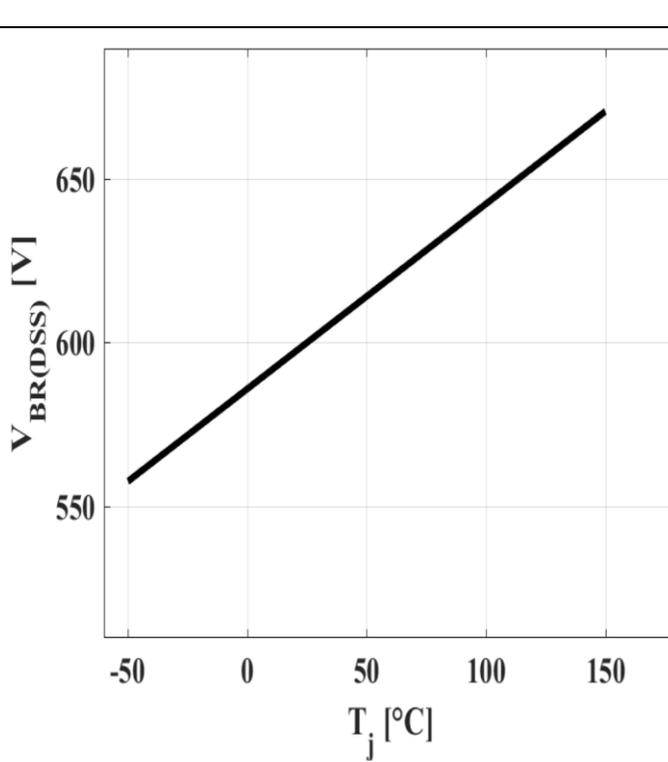
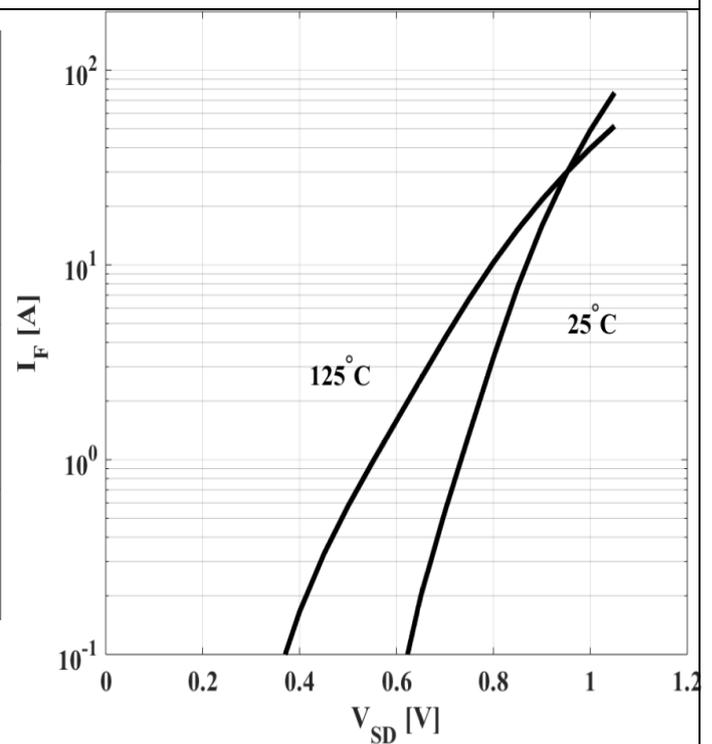
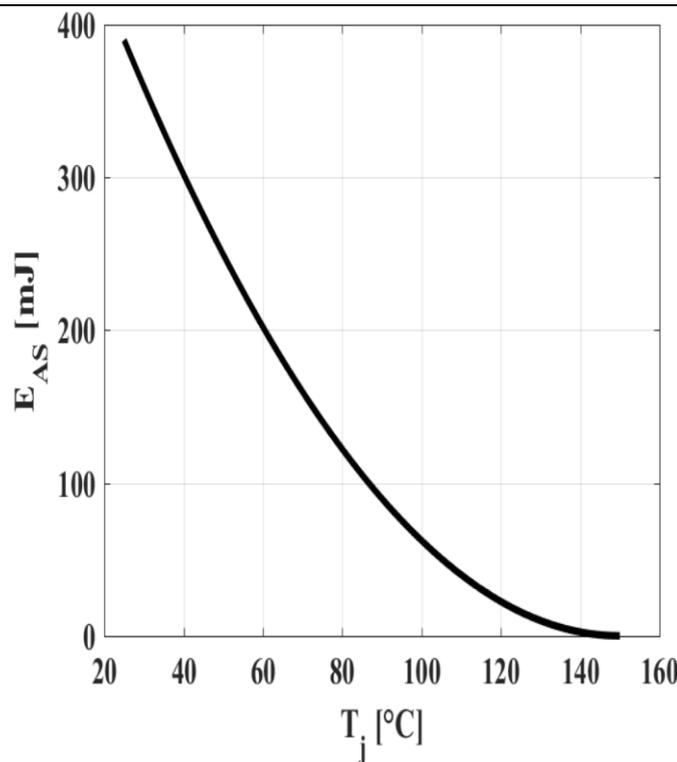
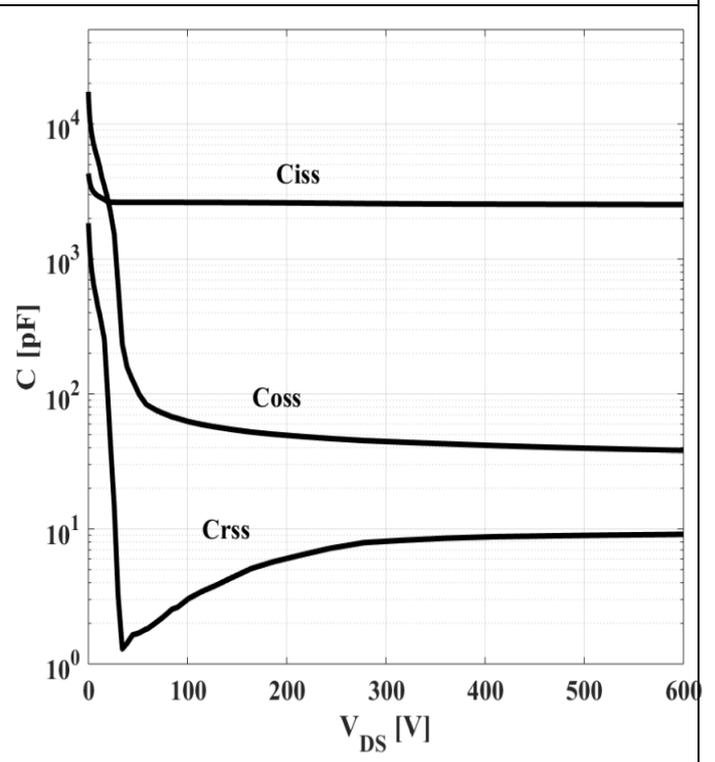
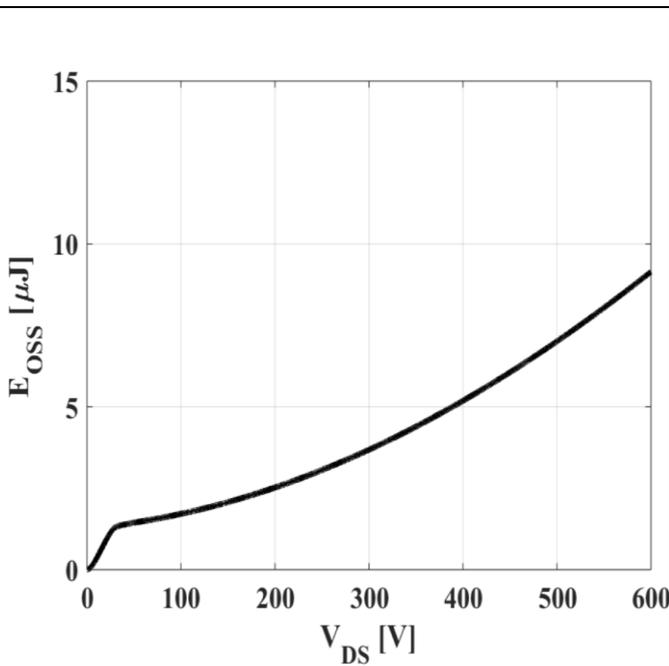
Figure 11: Typ. Transfer Characteristics

 $I_D = f(V_{GS}); V_{DS} = 20\text{V}$
Figure 12: Typ. Gate Charge

 $V_{GS} = f(Q_{gate}), I_D = 16\text{A pulsed}$
Figure 13: Drain-Source Breakdown Voltage

 $V_{BR(DSS)} = f(T_j); I_D = 1\text{mA}$
Figure 14: Forward Characteristics of Reverse Diode

 $I_F = f(V_{SD}); \text{parameter: } T_j$

Figure 15: Avalanche Energy


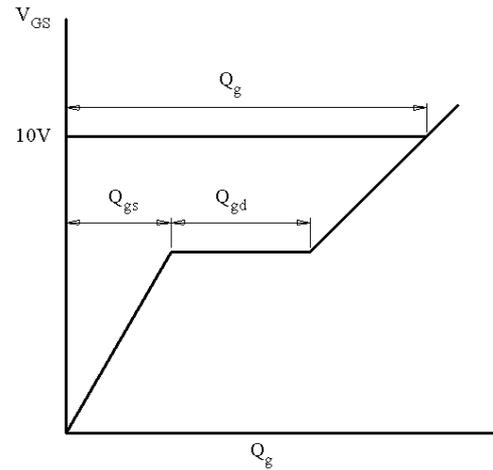
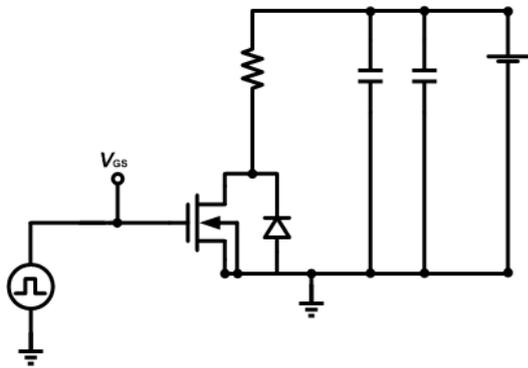
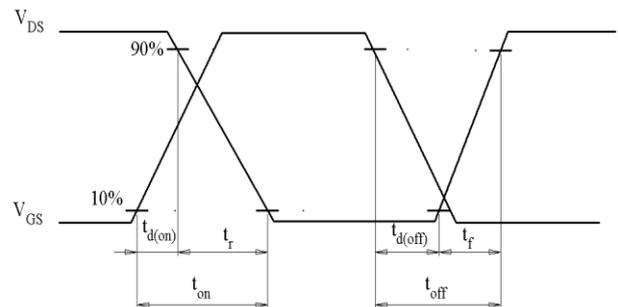
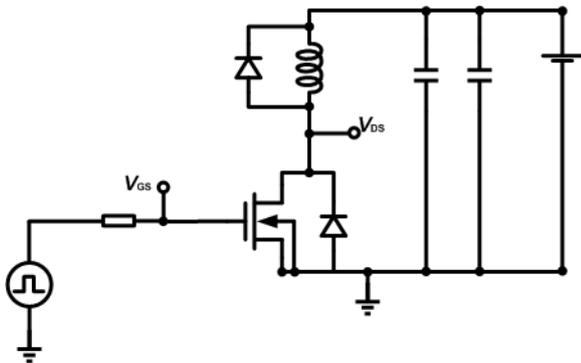
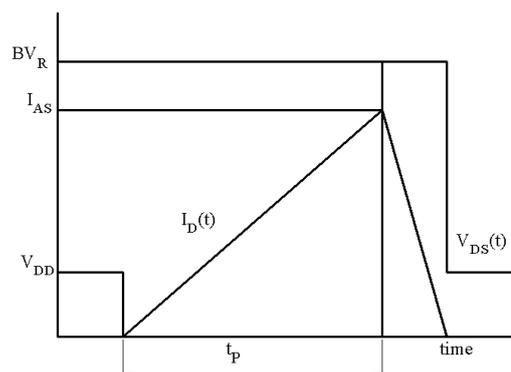
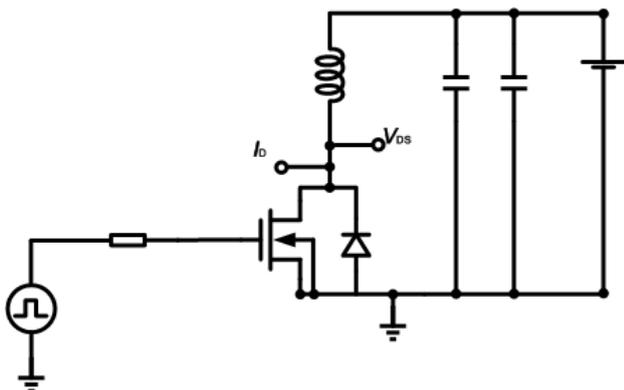
$$E_{AS}=f(T_j); I_D=3.0A; V_{DD}=60V$$

Figure 16: Typ. Capacitances


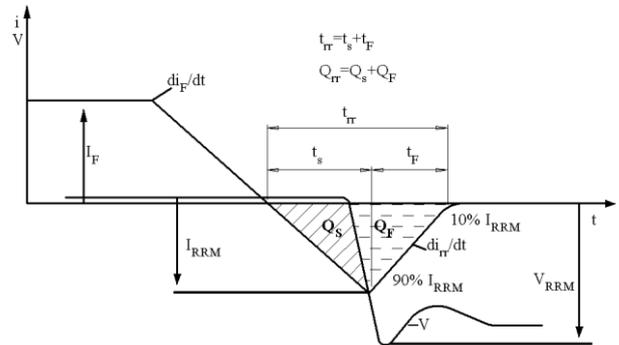
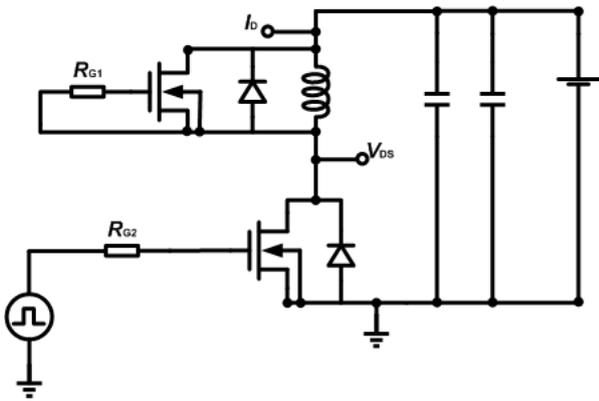
$$C=f(V_{DS}); V_{GS}=0; f=1MHz$$

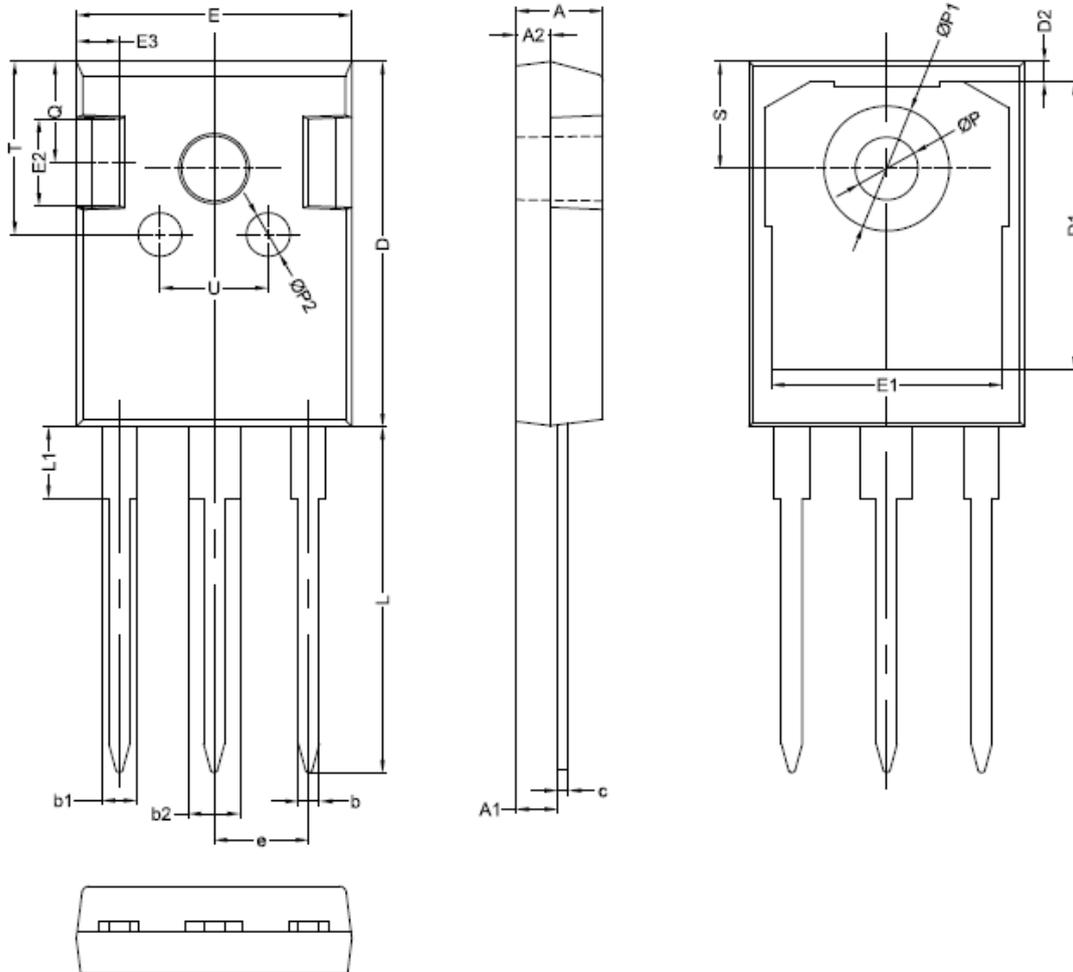
Figure 17: C_oss Stored Energy


$$E_{OSS}=f(V_{DS})$$

Test Circuits
1. Gate Charge Test Circuit & Waveform

2. Switch Time Test Circuit

3. Unclaimed Inductive Switching Test Circuit & Waveforms


4. Test Circuit and Waveform for Diode Characteristics

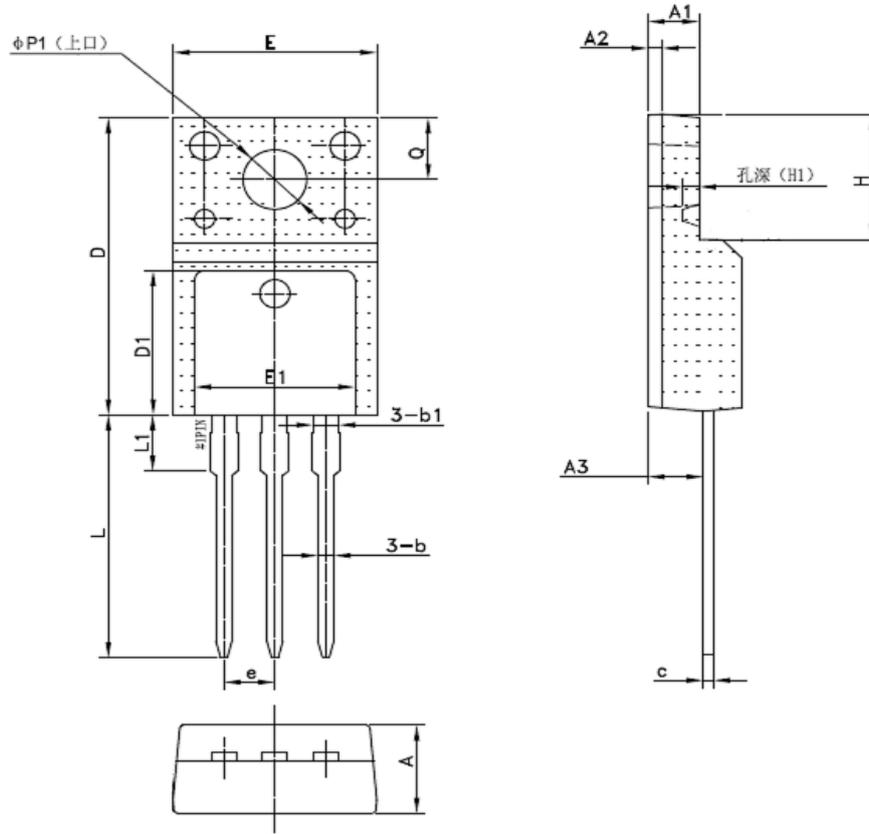


Mechanical Dimensions
TO-247
Unit: mm


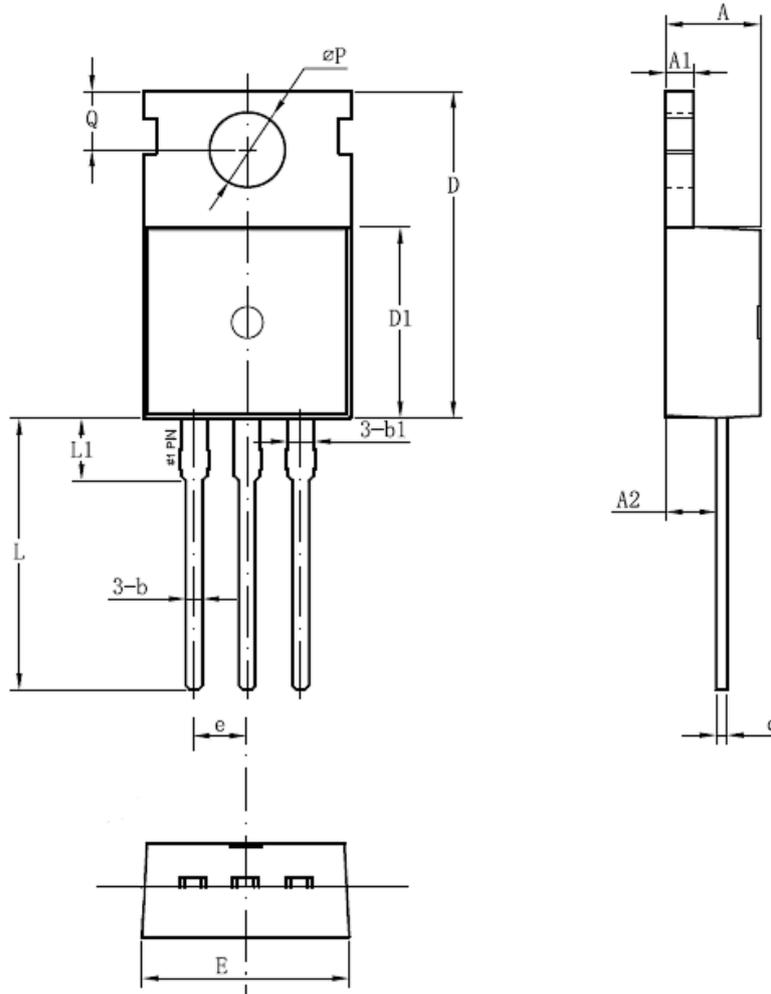
Symbol	Dimensions(mm)			Symbol	Dimensions(mm)		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.80	5.00	5.20	E2	-	5.00	-
A1	2.21	2.41	2.61	E3	-	2.50	-
A2	1.90	2.00	2.10	e	5.44(BSC)		
b	1.10	1.20	1.35	L	19.42	19.92	20.42
b1	-	2.00	-	L1	-	4.13	-
b2	-	3.00	-	P	3.50	3.60	3.70
c	0.55	0.60	0.75	P1	-	-	7.40
D	20.80	21.00	21.20	P2	-	2.50	-
D1	-	16.55	-	Q	-	5.80	-
D2	-	1.20	-	S	6.05	6.15	6.25
E	15.60	15.80	16.00	T	-	10.00	-
E1	-	13.30	-	U	-	6.20	-

Mechanical Dimensions(Continued)
TO-220F

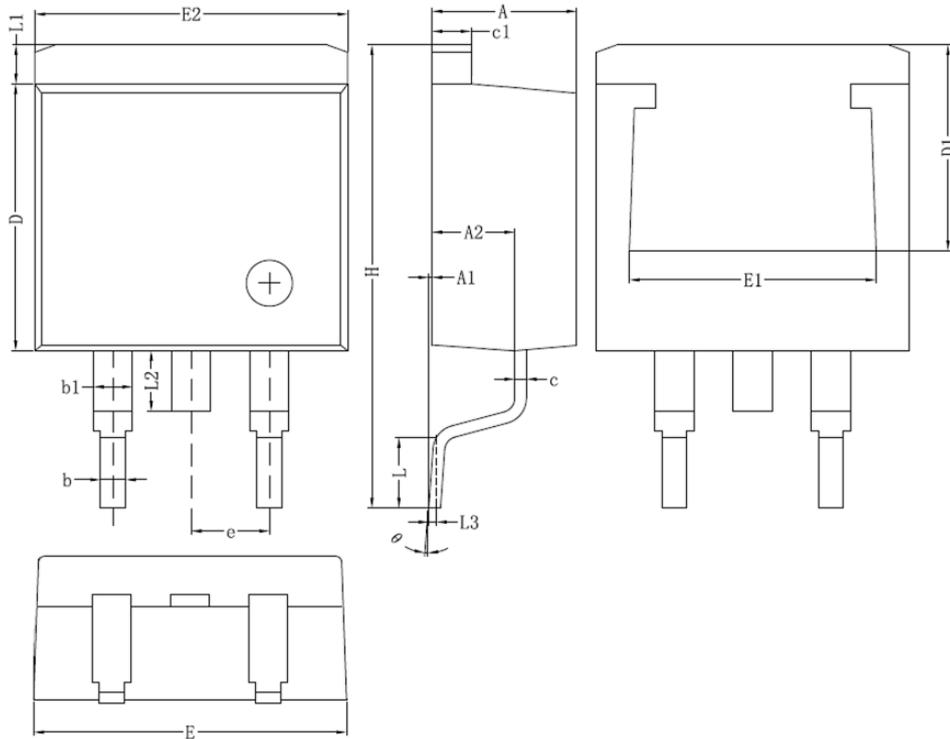
Unit: mm



Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	4.30	4.70	4.90
A1	2.34	2.54	2.90
A2	-	0.70	-
A3	2.56	2.76	2.96
b	0.55	-	0.95
b1	-	1.28	-
c	0.42	0.50	0.70
D	14.70	-	16.07
D1	-	7.70	-
E	9.96	10.16	10.36
E1	-	8.00	-
e	2.54(BSC)		
H	-	6.70	-
(H1)	-	(0.81)	-
L	12.48	12.98	13.50
L1	-	2.93	-
ΦP1	-	3.18	-
Q	2.90	3.30	3.50

Mechanical Dimensions (Continued)
TO-220C
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	4.30	4.50	4.70
A1	1.20	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b1	-	1.27	-
c	0.40	0.50	0.65
D	15.20	15.70	16.20
D1	9.00	9.20	9.40
E	9.70	10.00	10.20
e	2.54(BSC)		
L	12.60	13.08	13.60
L1	-	3.00	-
ΦP	3.50	3.60	3.80
Q	2.60	2.80	3.00

Mechanical Dimensions (Continued)
TO-263-2
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	4.30	4.60	4.85
A1	0.00	0.10	0.25
A2	2.59	2.69	2.89
b	0.70	0.81	0.96
b1	-	1.27	-
c	0.36	0.40	0.61
c1	1.15	1.27	1.40
D	8.55	-	9.40
D1	6.40	-	-
E	9.80	10.10	10.31
E1	7.60	-	-
E2	9.80	10.00	10.20
e	2.54(BSC)		
H	14.70	15.20	16.00
L	2.00	2.30	2.84
L1	1.00	1.27	1.40
L2	-	-	2.20
L3	-	0.25	-
θ	0°	-	8°



Shenzhen Sanrise Technology Co., LTD.

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Main Site:

- Headquarter

Shenzhen Sanrise Technology Co., LTD.
A1206, Skyworth building, No. 008, gaoxinnan 1st Road,
Gaoxin District, Yuehai street,, Nanshan District, ShenZhen,
P.R.China

Tel: +86-755-22953335

Fax: +86-755-22916878

- Shanghai Office

Shenzhen Sanrise Technology Co., LTD.
Rm.702, Building A, No. 666, Zhangheng Road,
Zhangjiang Hi-Tech Park, Shanghai, P.R.China

Tel: +86-21-68825918